

Substitute for form 1449A/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT <i>(Use as many sheets as necessary)</i>	Complete if Known	
	Application Number	10/626,031
	Filing Date	July 23, 2003
	First Named Inventor	Kenneth S. McElvain
	Group Art Unit	2823
	Examiner Name	Clark, Sheila V.
	Attorney Docket No	02986.P028
Sheet 1 of 2		

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/Sheila Clark/

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